

Extreme Broadband Silicon Capacitor XBSC 0201M 10nF BV11



Rev. 3.02

General description

XBSC Capacitor targets Optical communication system such as ROSA/TOSA, SONET and all optoelectronics as well as High speed data system or products. The XBSC is suitable for DC blocking, feedback, coupling and bypassing applications in all broadband optoelectronics and High-speed data system. The unique technology of integrated passive device in silicon, developed by Murata Integrated Passive Solutions, offers unique performances with low insertion loss, low reflection and phase stability from 160 KHz to 100 GHz+.

These capacitors in ultra-deep trenches in silicon have been developed in a semiconductor process, in order to integrate trench MOS capacitor providing high capacitance value of 10nF (for kHz–MHz range) and high frequency MIM capacitors for low capacitance value for GHz range), both in a SMT 0201M (0.6 x 0.3mm). The XBSC capacitor provides very high stability of the capacitance over temperature, voltage variation as well as a very high reliability. XBSC capacitors have an extended operating temperature ranging from -55 to 150°C, with very low capacitance change over temperature (+70ppm/K).

Assembly: flip chip applications through existing laminated packages or rigid PCB, ceramic substrate, FR4 or flex platforms suitable.

Bump finishing: SAC305 type 6.

Copper pads optional for embedding version and ENIG for un-bumped version, as an optional finishing.

Key features

- Extreme Broadband performance up to 110 GHz
- Resonance free
- Phase stability
- Insertion loss < 0.9dB Typ. up to 100 GHz.
- Ultra-high stability of capacitance value:
 - Temperature 70ppm/K (-55 °C to +150 °C)
 - Voltage <-0.1%/Volt
 - Negligible capacitance loss through ageing
- Low profile: 140 µm including bump height (SAC305 40µm bumps after reflow)
- Break down voltage: 11V
- Low leakage current < 100pA
- High reliability
- High operating temperature (up to 150 °C)
- Compatible with high temperature cycling during manufacturing operations (exceeding 300 °C)
- Compatible with EIA 01005 footprint and with EIA 0201 outline

Key applications

- ROSA/TOSA
- SONET
- High speed digital logic
- Microwave/millimetre system
- High volumetric efficiency (*i.e.* capacitance *per unit* volume)
- Broadband test equipment



Functional diagram

The next figure provides implementation set-up diagram.



Figure 1 Block Diagram

Electrical performances

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
C	Capacitance value	@+25°C	-	10	-	nF
ΔC_P	Capacitance tolerance ⁽¹⁾	@+25°C	-15	-	+15	%
T _{OP}	Operating temperature		-55	20	150	°C
T _{STG}	Storage temperature ⁽²⁾		-70	-	165	°C
ΔC_T	Capacitance temp. variation	-55 °C to 150 °C	-	70	-	ppm/K
RV _{DC}	Rated voltage ⁽³⁾		-	-	3.8 ⁽⁴⁾ 3.4 ⁽⁵⁾	V _{DC}
BV	Break down voltage	@+25°C	11	-	-	V
ΔC_{RVDC}	Capacitance voltage variation	From 0 V to RV _{DC} , @+25°C	-	-	-0.1	%/V _{DC}
IR	Insulation resistor	@RV _{DC} , +25°C, 120s	-	10	-	GΩ
ESL	Equivalent Serial Inductance	@+25°C, SRF shunt mode	-	100	-	pH
ESR	Equivalent Serial Resistance	@+25°C, shunt mode	-	300	-	mOhm
F _{c-3dB}	Cut-off frequency at 3dB	@+25°C	-	160	187	kHz
IL	Insertion loss	@ 20 GHz, +25°C	-	0.2	-	dB
		@ 40 GHz, +25°C	-	0.3	-	dB
		@ 60 GHz, +25°C	-	0.4	-	dB
		@ 100 GHz, +25°C	-	0.9	-	dB
RL	Return loss	Up to 100 GHz, +25°C	15	-	-	dB
ESD	HBM stress ⁽⁶⁾	JS-001-2017	8	-	-	kV

Table 1 - Electrical performances

⁽¹⁾: other tolerance available upon request.

⁽²⁾: without packaging.

⁽³⁾: Lifetime is voltage and temperature dependent, please refer to application note 'Lifetime of 3D capacitors'.

⁽⁴⁾: 10 years of intrinsic life time prediction at 100°C continuous operation.

⁽⁵⁾: 10 years of intrinsic life time prediction at 150°C continuous operation.

⁽⁶⁾: please refer to application note 'ESD Challenge in 3D Murata Integrated Passive technology'.

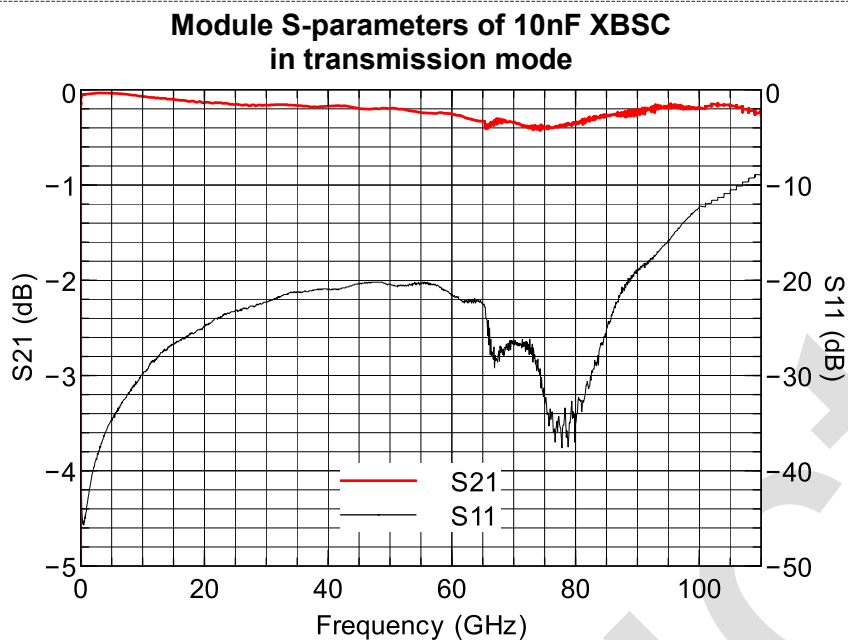
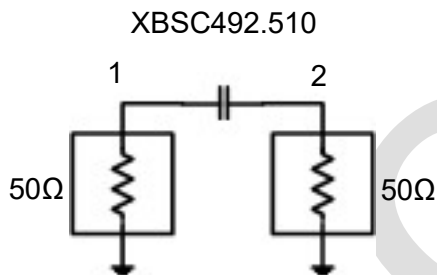


Figure 2 - 10nF XBSC measurement results (module of S-parameters)

Schematic of 10nF XBSC in transmission mode



10-mil thick Quartz substrate
 coplanar waveguide (CPW) - line width = 0.180mm and gap = 0.20mm (nominal)
 50 Ohm characteristic impedance

Figure 3 - 10nF XBSC measurement schematic

Example of surface mounted 0201M

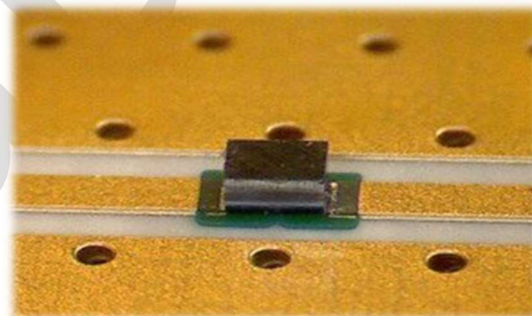


Figure 4 – micro picture of XBSC mounted on board in coplanar mode



FREE S-Parameters-Based Linear Simulation Models for ADS

<http://www.modelithics.com/mvpmurata.asp>



Pinning definition

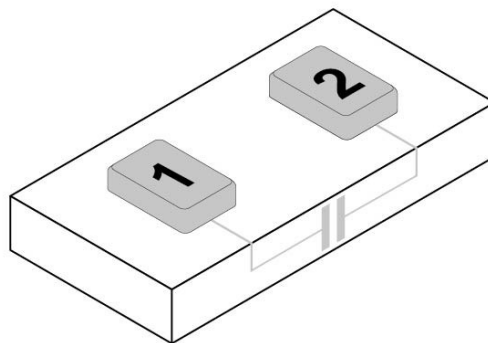


Figure 5 Pin configuration

pin #	Symbol	Coordinates X / Y
1	Signal	-150.0 / 0.0
2	Signal	150.0 / 0.0

Table 2 - Pining description. Reference (0,0) located at the centre of the die.

Ordering Information for XBSC492.510

Regardless of packaging, Murata Integrated Passive Devices delivers products with AQL level II (0.65).

Type number	Package		
	Packaging	Finishing	Description
939118492510-T3S	7" T&R (1 000 pieces/reel) ⁽²⁾	SAC ⁽¹⁾	XBSC 0201M - 10nF – 2 pads – 0.6 x 0.3 mm x 0.10mm ⁽³⁾
939118492510-T3N	7" T&R (1 000 pieces/reel) ⁽²⁾	ENIG ⁽¹⁾	XBSC 0201M - 10nF – 2 pads – 0.6 x 0.3 mm x 0.10mm ⁽³⁾

(1) S = ENIG (0.1µm Au / 5µm Ni) + SAC305 type 6 or N = ENIG (0.1µm Au / 5µm Ni)

(2) Missing capacitors can reach 0.5%

(3) Refer to Figure9

Table 3 - Packaging and ordering information

Product Name	Die Name	Description
XBSC492.510	XM0201510	XBSC 10nF/0201M/BV11 – 2 pads – 0.6 x 0.3 x 0.10 mm

Table 4 - Die information



Pad Metallization

This surface mounted Silicon Capacitor is delivered as standard with SAC305 type 6 bumping (Refer to Figure6).

Other Metallization, such as ENIG (0.1µm Au / 5µm Ni) (Refer to Figure7), Copper, Thick Gold or Aluminum pads are possible on request.

Silicon dies are not sensitive to humidity, please refer to applications notes ‘Assembly Notes’ section ‘Handling precautions and storage’.

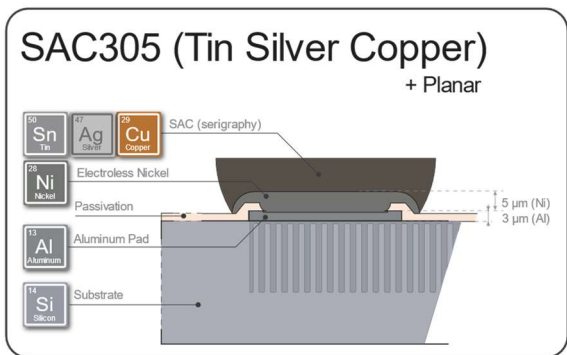


Figure 6 – Top electrode description of SAC305 pre-bumped version

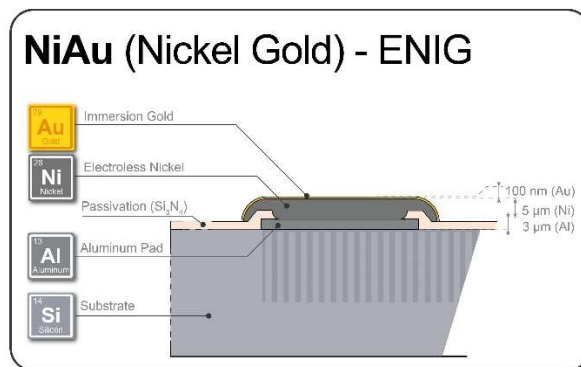


Figure 7 – Top electrode description of ENIG finishing version

Material regulation

This product is RoHS compliant at the time of publication. For further information about regulation compliancy, please ask your sales representative.

Package outline

The product is delivered as a bare silicon die.

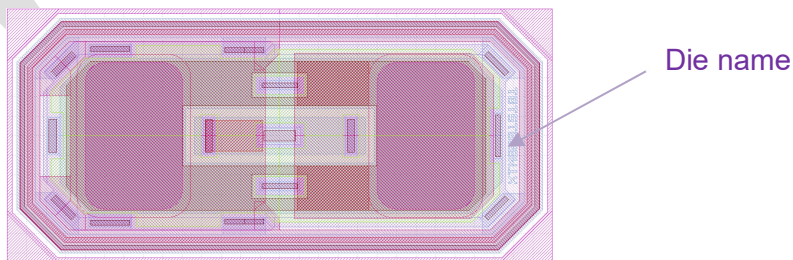


Figure 8 – Layout view

L (mm)	W (mm)	T (mm)	c (mm)	p (mm)	e (mm)	t (mm)
0.60 ±0.02	0.30 ±0.02	0.10 ±0.01	0.10	0.20	0.15	0.04 ⁽¹⁾ 0.05 ⁽²⁾ 0.005 ⁽³⁾

(1) Standard with solder joint height after reflow on board.
 (2) Standard with solder bump height before assembly
 (3) Only in case of ENIG finishing



Table 5 - Dimensions and tolerances

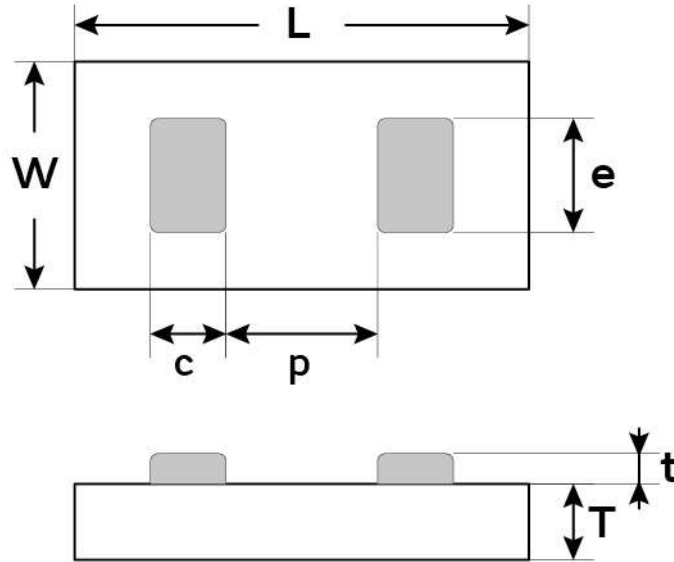


Figure 9 - Package outline drawing

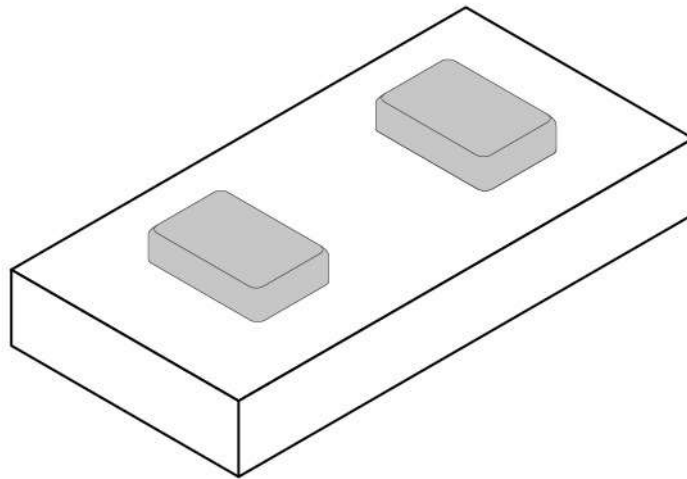


Figure 10 Isometric view



Assembly

XBSC series is compatible with standard reflow technology.

It is recommended to design mirror pads on the PCB.

For further information, please see our mounting application note

The attachment techniques recommended by Murata on the customer's substrates are fully detailed in specific documents available on our website. To assure the correct use and proper functioning of Murata capacitors **please download the assembly instructions on <https://www.murata.com/en-us/products/capacitor/siliconcapacitors>** and read them carefully.



Figure 11 Scan this QR Code to access the Murata Silicon Capacitor web page

Product



Packaging format

Please refer to application note 'Products Storage Conditions and Shelf Life'.

Tape and Reel: Dies are flipped in the tape cavity (bump down) with die ID located near the driving holes of the tape.

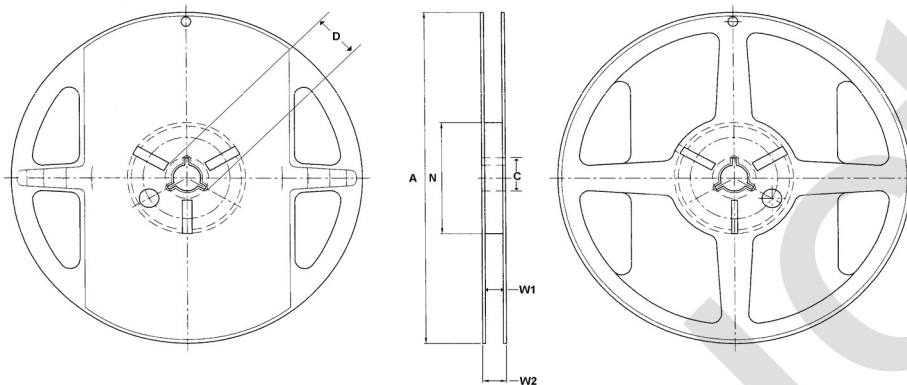


Figure 12 - Reel drawing

Tape Width	Diameter A	C	D	Hub N	W1	W2
8	178 (7 inches)	13.5	21	60	9.5	11.4

Table 6 - Reel dimensions (mm)

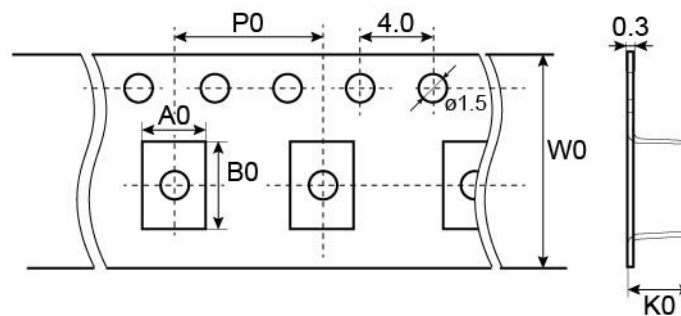


Figure 13 - Tape drawing

Cavity dimensions			Carrier tape width W0	Carrier tape pitch P0	Reel Capacity
Ao	Bo	Ko			
0.37 ± 0.04	0.67 ± 0.04	0.20 ± 0.04	8.00	2.00	1000 or 5000

Table 7 - Tape dimensions (mm)



Definitions

Data sheet status

Objective specification: This data sheet contains target or goal specifications for product development.

Preliminary specification: This data sheet contains preliminary data; supplementary data may be published later.

Product specification: This data sheet contains final product specifications.

Limiting values: Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those given in the Electrical performances sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information: Where application information is given, it is advisory and does not form part of the specification.

Revision history

Revision	Date	Description	Author.
Release 1.0	2017 Nov 22nd	Objective specification	OGA
Release 1.05	2020 Sept 15 th	General update	OGA ; SCA
Release 1.06	2020 Sept 17 th	Update on packaging	OGA ; SCA
Release 3.00	2021 May 05 th	Product update	OGA, DDE, DY0, LLE. SCA; CGU
Release 3.01	2023 March 10 th	Packaging update	CGU; OGA
Release 3.02	2023 May 31st	Adding of finishings cross section	CGU; OGA ; SCA ; CCO

Disclaimer / Life support applications

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